INTEGRATED CIRCUITS

DATA SHEET

74F280B9-bit odd/even parity generator/checker

Product specification

1996 Mar 12

IC15 Data Handbook





9-bit odd/even parity generator/checker

74F280B

FEATURES

- High-impedance NPN base inputs for reduced loading (20μA in Low and High states)
- Buffered inputs one normalized load
- Word length easily expanded by cascading
- Industrial temperature range available (-40°C to +85°C)

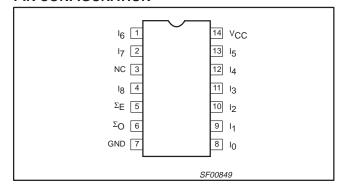
DESCRIPTION

The 74F280B is a 9-bit Parity Generator or Checker commonly used to detect errors in high speed data transmission or data retrieval systems. Both Even (Σ_{E}) and Odd (Σ_{O}) parity outputs are available for generating or checking even or odd parity on up to 9 bits.

The Even (Σ_E) parity output is High when an even number of Data inputs $(I_0 - I_8)$ are High. The Odd (Σ_O) parity output is High when an odd number of Data inputs are High.

Expansion to larger word sizes is accomplished by tying the Even (Σ_E) outputs of up to nine parallel devices to the data inputs of the final stage. This expansion scheme allows an 81-bit data word to be checked in less than 20ns.

PIN CONFIGURATION



TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F280B	5.5ns	26mA

ORDERING INFORMATION

DESCRIPTION	COMMERCIAL RANGE V_{CC} = 5V \pm 10%, T_{amb} = 0°C to +70°C	INDUSTRIAL RANGE V_{CC} = 5V $\pm 10\%$, T_{amb} = -40° C to $+85^{\circ}$ C	PKG. DWG. #
14-pin plastic DIP	N74F280BN	I74F280BN	SOT27-1
14-pin plastic SO	N74F280BD	I74F280BD	SOT108-1

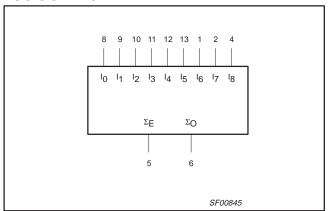
INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

PINS	DESCRIPTION	74F(U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
I ₀ - I ₈	Data inputs	1.0/0.033	20μΑ/20μΑ
Σ_{E}, Σ_{O}	Parity outputs	50/33	1.0mA/20mA

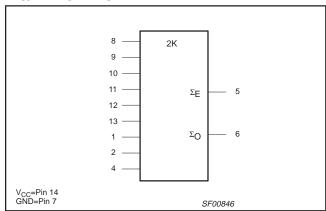
NOTE

One (1.0) FAST Unit Load is defined as: 20µA in the High state and 0.6mA in the Low state.

LOGIC SYMBOL



IEC/IEEE SYMBOL

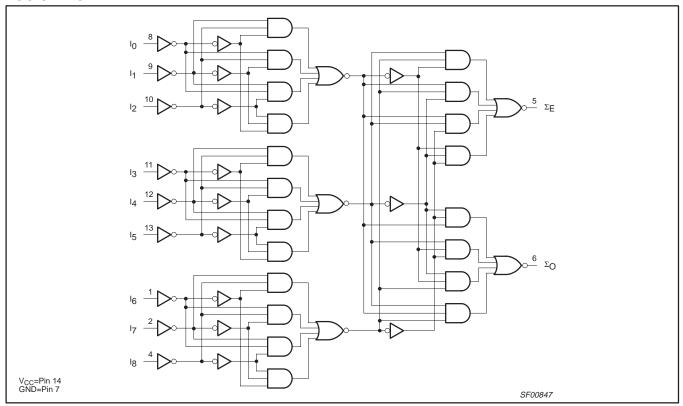


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LOGIC DIAGRAM



FUNCTION TABLE

INPUTS	OUTPUTS				
Number of High Data Inputs (I ₀ - I ₈)	Σ_{E}	Σ_{O}			
Even — 0, 2, 4, 6, 8	Н	L			
Odd — 1, 3, 5, 7, 9	L	Н			

H = High voltage level
L = Low voltage level

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ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETE	R	RATING	UNIT		
V _{CC}	Supply voltage		-0.5 to +7.0	V		
V _{IN}	Input voltage		-0.5 to +7.0			
I _{IN}	Input current	−30 to +5	mA			
V _{OUT}	Voltage applied to output in High output state	–0.5 to V _{CC}	V			
l _{OUT}	Current applied to output in Low output state		40	mA		
_	Operation from air temperature range	Commercial range	0 to +70	°C		
T _{amb}	Operating free-air temperature range	-40 to +85	°C			
T _{stg}	Storage temperature	-65 to +150	°C			

RECOMMENDED OPERATING CONDITIONS

CVMDOL	PARAMETER			LIMITS		LINUT
SYMBOL	PARAMETER		Min	Nom	Max	UNIT
V _{CC}	Supply voltage	4.5	5.0	5.5	V	
V _{IH}	High-level input voltage	2.0			V	
V _{IL}	Low-level input voltage			0.8	V	
I _{IK}	Input clamp current				-18	mA
Іон	High-level output current				-1	mA
l _{OL}	Low-level output current				20	mA
_	Operating free air temperature range	Commercial range	0		70	°C
T _{amb}	Operating free-air temperature range	-40		85	°C	

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAME	TED	TEST CONDITION	NIC1		LIMITS		UNIT
STWIBOL	TANAME	ILK	TEST CONDITIO	MIN	TYP ²	MAX	ONT	
V	High level output voltage		$V_{CC} = MIN, V_{IL} = MAX$	2.5			٧	
V _{OH}	High-level output voltage		$V_{IH} = MIN, I_{OH} = MAX$	±5%V _{CC}	2.7	3.4		V
\ <u></u>	Lave laved autaut valtage		$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}		0.35	0.50	V
V _{OL}	Low-level output voltage		$V_{IH} = MIN, I_{OL} = MAX$	±5%V _{CC}		0.35	0.50	V
V _{IK}	Input clamp voltage		$V_{CC} = MIN, I_I = I_{IK}$	_		-0.73	-1.2	V
I _I	Input current at maximum	n input voltage	$V_{CC} = 0.0V, V_I = 7.0V$				100	μΑ
	Lligh lovel input gurrent	Commercial range	V MAY V 27V				20	μΑ
¹ıH	High-level input current	Industrial range	$V_{CC} = MAX, V_I = 2.7V$				40	μΑ
I _{IL}	Low-level input current		$V_{CC} = MAX, V_I = 0.5V$				-20	μΑ
I _{OS}	Short-circuit output current ³		V _{CC} = MAX		-60		-150	mA
I _{CC}	Supply current (total)		V _{CC} = MAX			26	35	mA

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^{1.} For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

All typical values are at V_{CC} = 5V, T_{amb} = 25°C.
 Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, IOS tests should be performed last.

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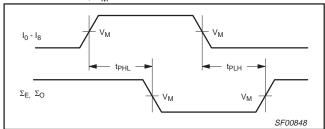
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AC ELECTRICAL CHARACTERISTICS

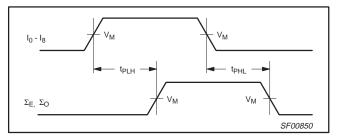
							LII	MITS			
SYMBOL	PARAMETE	TEST CONDITIONS	T_{amb} = +25°C V_{CC} = +5.V C_L = 50pF, R_L = 500 Ω			T _{amb} = 0°C V _{CC} = +5 C _L = 5 R _L =	.V ± 10%	T _{amb} = -40° V _{CC} = +5 C _L = 9 R _L =	UNIT		
			Min	Тур	Max	Min	Max	Min	Max		
t _{PLH} t _{PHL}	Propagation delay $I_0 - I_8$ to Σ_E	74F280B	Waveform 1, 2	4.0 4.0	6.5 7.0	9.0 10.0	3.5 3.5	10.0 11.1	3.0 3.5	11.0 12.0	ns ns
t _{PLH}	Propagation delay $I_0 - I_8$ to Σ_0	/4FZ0UB	Waveform 1, 2	4.0 4.0	6.5 7.0	9.0 10.0	3.5 3.5	10.0 11.0	3.0 3.5	11.0 12.0	ns ns

AC WAVEFORMS

For all waveforms, V_M=1.5V.

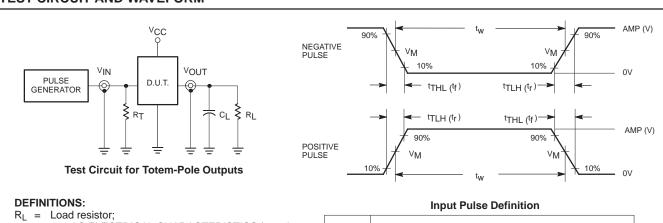


Waveform 1. Propagation Delay for Inverting Outputs



Waveform 2. Propagation Delay for Non-Inverting Outputs

TEST CIRCUIT AND WAVEFORM



see AC ELECTRICAL CHARACTERISTICS for value.

CL = Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.

 R_T = Termination resistance should be equal to Z_{OUT} of pulse generators.

family	INP	UT PU	LSE REQU	IREMEN	TS					
lallilly	amplitude V _M rep. rate t _w t _{TLH} t _T									
74F	3.0V	1.5V	1MHz	500ns	2.5ns	2.5ns				

SF00006

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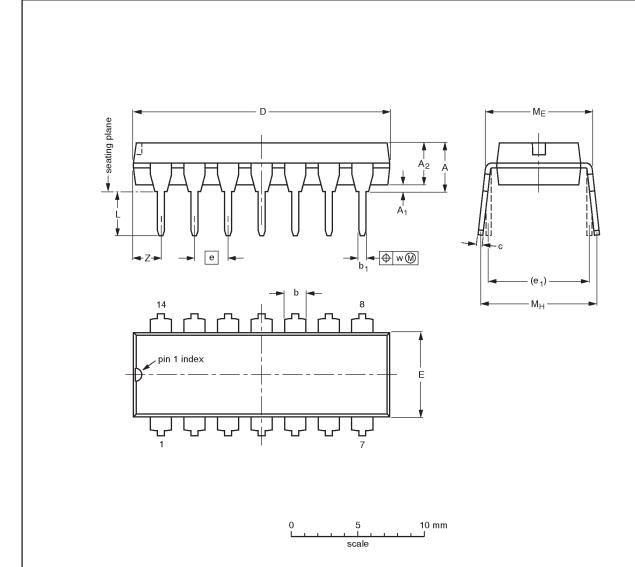
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DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	С	D ⁽¹⁾	E ⁽¹⁾	е	e ₁	L	ME	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.020	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT27-1	050G04	MO-001AA			92-11-17 95-03-11	

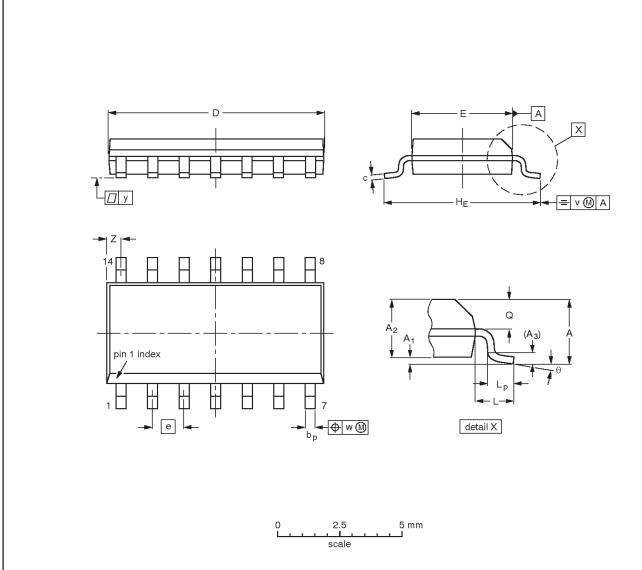
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SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	8.75 8.55	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075		0.16 0.15	0.050	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION		REFERENCES			EUROPEAN	ISSUE DATE
	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT108-1	076E06S	MS-012AB				-95-01-23- 97-05-22

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Data sheet status

Data sheet status	Product status	Definition [1]	
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.	
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.	
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible produc	

^[1] Please consult the most recently issued datasheet before initiating or completing a design.

Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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